

< HIGH VOLTAGE DIODE MODULES >

RM250DG-130F

HIGH POWER SWITCHING USE
INSULATED TYPE

High Voltage Diode Modules

RM250DG-130F



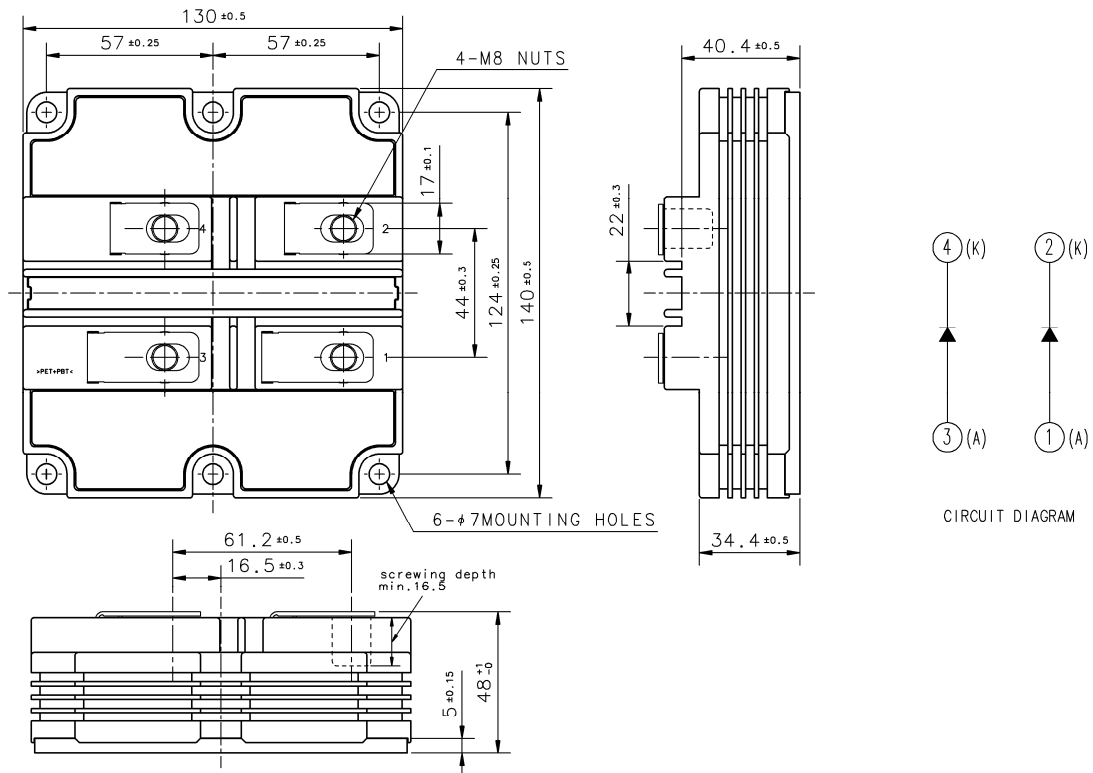
- I_F250A
- V_{RRM}6500V
- 2-element in a Pack
- High insulated Type
- Soft Recovery Diode
- AISiC Baseplate

APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



RM250DG-130FHIGH POWER SWITCHING USE
INSULATED TYPE**MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
V_{RRM}	Repetitive peak reverse voltage	$T_j = +125^\circ\text{C}$	6500	V
		$T_j = +25^\circ\text{C}$	6300	
		$T_j = -50^\circ\text{C}$	5700	
V_{RSM}	Non-repetitive peak reverse voltage	$T_j = +125^\circ\text{C}$	6500	V
		$T_j = +25^\circ\text{C}$	6300	
		$T_j = -50^\circ\text{C}$	5700	
I_F	Collector current	DC, $T_c = 65^\circ\text{C}$	250	A
I_{FRM}		Pulse ^(Note 1)	500	A
I_{FSM}	Surge (non-repetitive) forward current	$T_{L_start} = 125^\circ\text{C}$, $t_p = 10$ ms, Half-sine wave, $V_R = 0$ V	2350	A
I_t^2	Surge current load integral		28	kA^2s
V_{iso}	Isolation voltage	RMS, sinusoidal, $f = 60$ Hz, $t = 1$ min.	10200	V
V_e	Partial discharge extinction voltage	RMS, sinusoidal, $f = 60$ Hz, $Q_{PD} \leq 10$ pC	5100	V
T_j	Junction temperature		$-50 \sim +150$	$^\circ\text{C}$
T_{jop}	Operating junction temperature		$-50 \sim +125$	$^\circ\text{C}$
T_{stg}	Storage temperature		$-55 \sim +125$	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
I_{RRM}	Repetitive reverse current	$V_{RM} = V_{RRM}$	$T_j = 25^\circ\text{C}$	—	—	2.0	mA
			$T_j = 125^\circ\text{C}$	—	2.0	10.0	
V_{FM}	Forward voltage	$I_F = 250$ A ^(Note 2)	$T_j = 25^\circ\text{C}$	—	3.30	—	V
			$T_j = 125^\circ\text{C}$	—	3.40	4.30	
t_{rr}	Reverse recovery time	$V_{CC} = 3600$ V $I_F = 250$ A $L_s = 150$ nH	$T_j = 25^\circ\text{C}$	—	0.50	—	μs
			$T_j = 125^\circ\text{C}$	—	0.60	—	
I_{rr}	Reverse recovery current	$L_s = 150$ nH	$T_j = 25^\circ\text{C}$	—	260	—	A
			$T_j = 125^\circ\text{C}$	—	290	—	
Q_{rr}	Reverse recovery charge	$-d_i/d_t =$ 1250 A/ μs @ $T_j = 25^\circ\text{C}$ 1100 A/ μs @ $T_j = 125^\circ\text{C}$	$T_j = 25^\circ\text{C}$	—	240	—	μC
			$T_j = 125^\circ\text{C}$	—	340	—	
$E_{rec(10\%)}$	Reverse recovery energy ^(Note 3)	Inductive load	$T_j = 25^\circ\text{C}$	—	0.30	—	J
			$T_j = 125^\circ\text{C}$	—	0.60	—	
E_{rec}	Reverse recovery energy ^(Note 4)	Inductive load	$T_j = 25^\circ\text{C}$	—	0.40	—	J
			$T_j = 125^\circ\text{C}$	—	0.80	—	

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INSULATED TYPE**THERMAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$R_{th(j-c)}$	Thermal resistance	Junction to Case (per 1/2 module)	—	—	75.0	K/kW
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, $\lambda_{grease} = 1 \text{ W/m}^2\text{K}$ $D_{(c-s)} = 100 \mu\text{m}$ (per 1/2 module)	—	48.0	—	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
M_t	Mounting torque	M8 : Main terminals screw	7.0	—	22.0	N·m
M_s		M6 : Mounting screw	3.0	—	6.0	N·m
m	Mass		—	1.0	—	kg
CTI	Comparative tracking index		600	—	—	—
d_a	Clearance		26.0	—	—	mm
d_s	Creepage distance		56.0	—	—	mm
$L_{P AK}$	Parasitic stray inductance	1/2 module	—	44.0	—	nH
R_{AA+KK}	Internal lead resistance	$T_c = 25^\circ\text{C}$, 1/2 module	—	0.27	—	mΩ

Note 1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{opmax} rating (125°C).

Note 2. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note 3. $E_{rec(10\%)}$ is the integral of $0.1V_R \times 0.1I_F \times dt$.

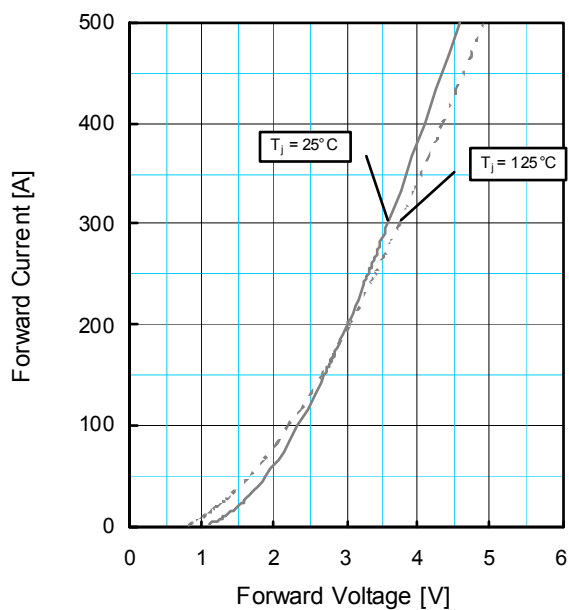
Note 4. The integration range of E_{rec} according to IEC 60747.

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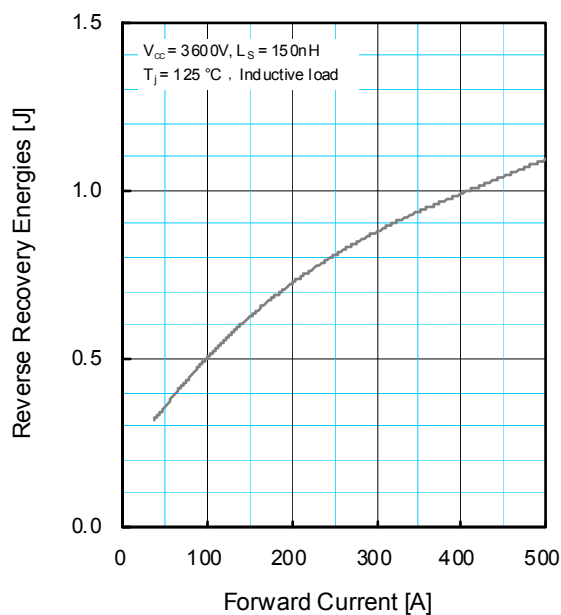
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

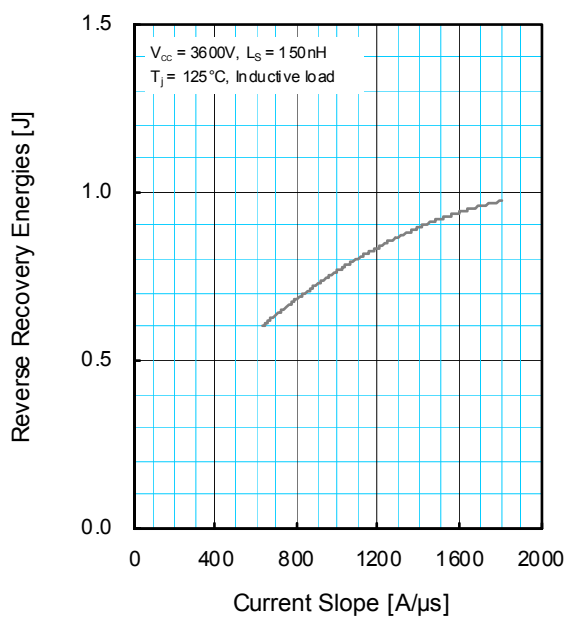
FORWARD CHARACTERISTICS (TYPICAL)



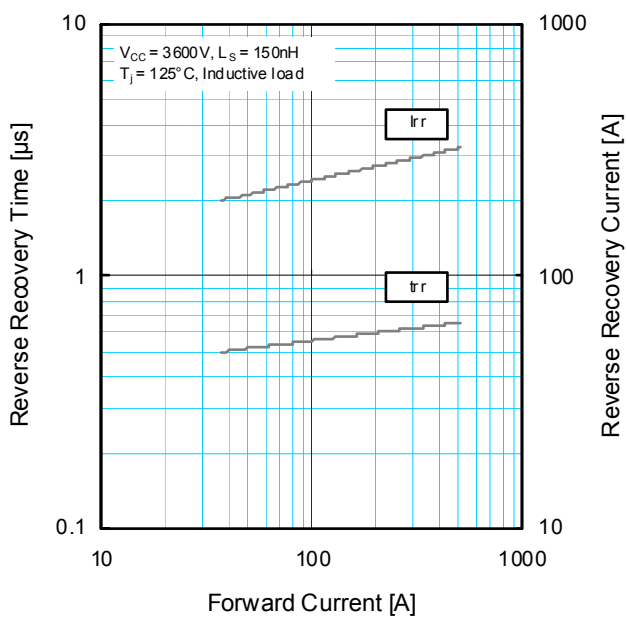
REVERSE RECOVERY ENERGY CHARACTERISTICS (TYPICAL)



REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

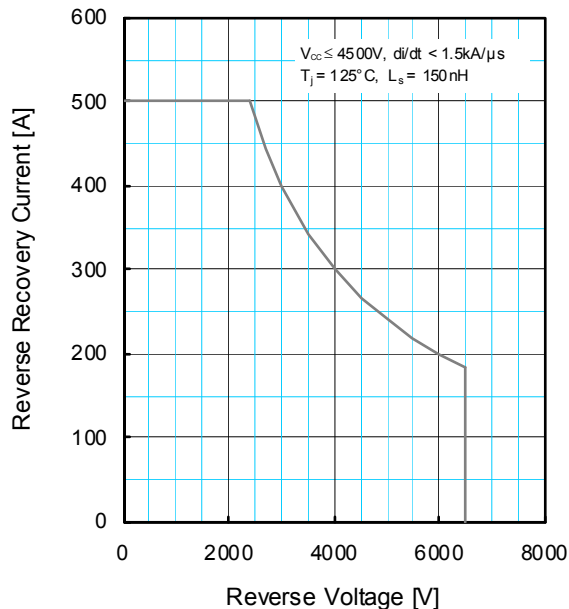


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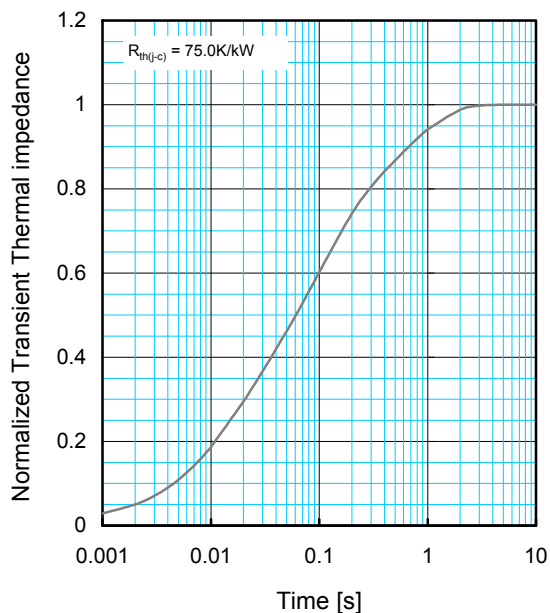
HIGH POWER SWITCHING USE
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PERFORMANCE CURVES

REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
R_i [K/kW]	0.0055	0.2360	0.4680	0.2905
τ_i [sec]	0.0001	0.0131	0.0878	0.6247

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